

Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as Spectrum Analyzers, Signal Generators, Oscilloscopes, Power Meters, Network Analyzers etc from all the major suppliers such as Keysight, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. We fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 1 year warranty. Our staff have extensive backgrounds in T&M which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, presenting flexible technical + commercial solutions and supplying a loan unit during warranty repair, if available.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based in at Oakley, Bedfordshire in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our 40GHz in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

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9350A Family Digital Oscilloscopes

500 MHz Bandwidth, 2 GS/s

Main Features

- **Two and Four Channel versions**
- **Up to 8M Point record length**
- **DOS Compatible Floppy Disk, PCMCIA portable hard drive and Memory Card options**
- **Innovative Peak Detect Mode**
- **Glitch, Pattern, Qualified, Interval, Dropout and Video Triggers**
- **8-bit vertical resolution, 11 with ERES option**
- **Fully programmable via GPIB and RS-232-C**
- **Automatic PASS/FAIL testing**
- **Advanced Signal Processing**
- **Internal High Resolution Graphics**

High speed and long memory make this family the ideal 500 MHz general-purpose Digital Storage Oscilloscopes. Two and four channel simultaneous sampling at 500 MS/s meets demanding high-speed design applications. Even faster sampling may be achieved by combining channels, up to a maximum of 2 GS/s. Acquisition memories may also be combined, providing up to 8 M points of continuous or segmented waveform recording. Repetitive signals are digitized at up to 10 GS/s.

A unique peak detect scheme triggers on glitches down to 1ns and keeps the ADC sampling at 2.5 ns - even at slow time bases - without destroying the underlying data. This provides circuit designers with the benefits of peak detection without any loss of precision.

Live waveforms on the main timebase may be viewed simultaneously with up to 3 expansions, showing all of the signal detail. Expansions are shown as highlights on the main trace. Each zoomed detail may be expanded horizontally and vertically as required.

SMART Trigger modes like Glitch, Pattern, Dropout and TV allow you to capture precisely the events of interest. Pre- and Post-Trigger delay, and Time and Events Holdoff are also standard. The 9350A family features the proven user-interface of LeCroy's portable scopes. A bright 9" CRT allows optimum waveform viewing on a high resolution 810 x 696 pixel screen. Menus and text are arranged around the graticules - they never overwrite the waveforms. Dedicated control knobs keep the scope's performance at your fingertips.

A comprehensive range of signal processing functions including FFT and Math on live or stored waveforms, allows extensive waveform manipulation. Up to 16 MBytes of RAM are standard allowing advanced processing including FFT's up to 1 Mpoint. For the most powerful processing in the

industry, a 64 MByte RAM option is available. DOS compatible floppy disk, PCMCIA portable hard drive and memory card options store waveforms and test setups, and simplify data transfer to any PC. An optional high resolution graphics printer is also available.

ACQUISITION SYSTEM

Bandwidth (~3 dB): DC to 500 MHz

No. of Channels:

4 (9354A) or 2 (9350A)

No. of Digitizers:

4 (9354A) or 2 (9350A)

Maximum Sample Rate:

2 GS/s (9354A) or 1 GS/s (9350A)

Acquisition Memory: Up to 8 M (see table below).

Sensitivity: 2 mV/div to 5 V/div, fully variable.

Scale factors: A wide choice of over 12 probe attenuation factors are selectable.

Offset Range: 2.0 - 9.9 mV/div: ± 120 mV

10.0 - 199 mV/div: ± 1.2 V

0.2 - 5.0 V/div: ± 24 V

± 20 V across the whole sensitivity range when using the AP 020 FET probe.

DC Accuracy: < or equal to $\pm 2\%$ full scale.

Vertical Resolution: 8 bits.

Bandwidth Limiter: 30 MHz

Input Coupling: AC, DC, GND.

Input Impedance: 1 M Ohm//14 pF or 50 Ohms $\pm 1\%$.

Max Input:

1 M Ohm: 250 V (DC+peak AC < or equal to 10 kHz)

50 Ohms: ± 5 V DC (500 mW) or 5 V RMS

TIME BASE SYSTEM

Timebases: Main and up to 4 Zoom Traces.

Time/Div Range: 1 ns/div to 1000 s/div.

Clock Accuracy: < or equal to 10 ppm

Interpolator resolution: 10 ps

Roll Mode: Ranges 500 ms to 1,000 s/div.

For > 50k points: 10 s to 1,000 s/div.

External Clock: < or equal to 100 MHz on EXT input with ECL, TTL or zero crossing levels up to 500 MHz with option 935XA-CKTRIG.

TRIGGERING SYSTEM

Trigger Modes: Normal, Auto, Single.

Trigger Sources: CH1, CH2, Line, Ext, Ext/10 (9354: CH3, CH4), Slope, Level and Coupling for each can be set independently.

Slope: Positive, Negative.

Coupling: AC, DC, HF, LFREJ, HFREJ.

Pre-trigger recording: 0 to 100% of full scale (adjustable in 0.1 div increments).

Post-trigger delay: 0 to 10,000 divisions (adjustable in 0.01% increments).

Holdoff by time: 10 ns to 20 s.

Holdoff by events: 0 to 99,999,999 events.

Trigger Bandwidth: Up to 500 MHz using HF coupling.

Internal Trigger Sensitivity Range: ± 5 div.

EXT Trigger Max Input:

1 M Ohm//15 pF: 250 V (DC+peak AC < or equal to 10 kHz)

50 Ohms $\pm 1\%$: ± 5 V DC (500 mW) or 5 V RMS

EXT Trigger Range: ± 0.5 V (± 5 V with Ext/10)

Trigger Timing: Trigger Date and Time are listed in the Memory Status Menu.

SMART TRIGGER TYPES

Pattern: Trigger on the logic AND of 5 inputs - CH1, CH2, CH3, CH4, and EXT Trigger, (9350: 3 inputs - CH1, CH2, EXT) where each source can be defined as High, Low or Don't Care. The Trigger can be defined as the beginning or end of the specified pattern.

Signal or Pattern Width: Trigger on glitches as short as 1 nsec or on pulse widths between two limits selectable from < 2.5 ns to 20s.

Signal or Pattern Interval: Trigger on an interval between two limits selectable from 10ns to 20s.

Dropout: Trigger if the input signal drops out for longer than a time-out from 25ns to 20s.

State/Edge Qualified: Trigger on any source only if a given state (or transition) has occurred on another source. The delay between these events can be defined as a number of events on the trigger channel or as a time interval.

TV: Allows selection of both line (up to 1500) and field number (up to 8) for PAL, SECAM, NTSC or non-standard video.

ACQUISITION MODES

Random Interleaved Sampling (RIS):

for repetitive signals from 1 ns/div to 2 μ s/div (M,L versions: from 1 ns/div to 5 μ s/div).

Single shot: for transient and repetitive signals from 10 ns/div (all channels active).

Peak detect: captures and displays 2.5 ns glitches or other high-speed events.

Sequence: Stores multiple events - each of them time stamped - in segmented acquisition memories.

Number of segments available:

9350A-9354A	2-50
9350AM-9354AM-9354TM	2-500
9350AL-9354AL	2-2,000

DISPLAY

Waveform style: Vectors connect the individual sample points, which are highlighted as dots. Vectors may be switched off.

CRT: 12.5 x 17.5 cm (9" diagonal) raster.

Resolution: 810 x 696 points.

Modes: Normal, X-Y, Variable or Infinite Persistence.

Real-time Clock: Date, hours, minutes, seconds.

Graticules: Internally generated; separate intensity control for grids and waveforms.

Grids: 1, 2 or 4 grids.

Formats: YT, XY, and both together.

Vertical Zoom: Up to 5x Vertical Expansion (50x with averaging, up to 40 μ V sensitivity).

Horizontal Zoom Factors:

9350A-9354A 500x
9350AM-9354AM-9354TM 2,000x
9350AL-9354AL 40,000x

INTERNAL MEMORY

Waveform Memory: Up to four 16-bit Memories (M1,M2,M3,M4).

Processing Memory: Up to four 16-bit Waveform Processing Memories (A,B,C,D).

Setup Memory: Four non-volatile memories. Optional Cards or Disks may also be used for high-capacity waveform and setup storage.

AUTOMATIC MEASUREMENTS

The following Parametric measurements are available, together with statistics of their Average, Highest, Lowest values and Standard Deviation:

amplitude	delta t at level (t=0,abs)	overshoot +
area	delta t at level (t=0%)	overshoot -
base	duty cycle	peak to peak
cmean	falltime	period
cmedian	f80-20%	risetime
crms	f@level (abs)	r20-80%
csdev	f@level (%)	r@level (abs)
cycles	frequency	r@level (%)
delay	maximum	RMS
delta delay	mean	std dev
delta t at level (abs)	median	top

delta t at level (%)	minimum	width
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Parameters are calculated as defined by ANSI/IEEE Std 181-1977 "Standard on Pulse Measurement and Analysis by Objective Techniques". In addition, Rise and Fall times may be measured at 10 % and 90% levels, or 20% and 80% levels, or any other user-specified levels.

delta delay provides time between midpoint transition of two sources, for making propagation delay measurements.

delta t at level allows the same measurement to be made at any specified level.

Two cursors are used to define the region over which these parameters are calculated.

Relative Time: Two cursors provide time measurements with resolution of $\pm 0.05\%$ full scale for unexpanded traces; up to 10 % of the sampling interval for expanded traces. The corresponding frequency value is also displayed.

Relative Voltage: Two horizontal bars measure voltage differences up to $\pm 0.2\%$ of fullscale in single-grid mode.

Absolute Time: A cross hair marker measures time relative to the trigger, and voltage with respect to ground.

Pass/Fail testing allow up to five of the listed parameters to be tested against selectable thresholds. Waveform Limit Testing is performed using templates which may be defined inside the instrument.

WAVEFORM PROCESSING

Up to four processing functions may be performed simultaneously. Functions available are: Add, Subtract, Multiply, Divide, Negate, Identity, Sin (x)/x and Summation Averaging.

Average: Summed averaging of up to 1,000 waveforms in the basic instrument. Up to a million sweeps are possible with Option WP01.

Envelope*: Max, Min, or Max and Min values of up to one million sweeps.

ERES*: Low-Pass digital filter provides up to 11 bits vertical resolution.

Sampled data is always available, even when a trace is turned off. Any of the above modes can be invoked without destroying the data.

FFT*: Spectral Analysis with four windowing functions and FFT averaging.

*Envelope and ERES modes are provided in Math Package WP01, FFT is in WP02.

AUTOSETUP

Pressing Autosetup sets timebase, trigger and sensitivity to display a wide range of repetitive signals. (Amplitude 2mV to 40V; frequency above 50Hz; Duty cycle greater than 0.1%).

Autosetup Time: Approximately 2 seconds.

Vertical Find: Automatically sets sensitivity and offset.

PROBES

Model: One PP002 (X10, 10 M Ohm // 15 pF) probe supplied per channel.

The 9350 family is fully compatible with LeCroy's range of FET Probes, which may be purchased separately.

Probe calibration: Max 1 V into 1 M Ohm,

500 mV into 50 Ohms , frequency and amplitude programmable, pulse or square wave selectable, rise and fall time 1 ns typical.

Alternatively, the Calibrator output can provide a trigger output or a PASS/FAIL test output.

INTERFACING

Remote Control: All front-panel controls, as well as all internal functions are possible by GPIB and RS-232-C.

RS-232-C Port (Standard): Asynchronous up to 19200 baud for computer/terminal control or printer/plotter connection.

GPIB Port (Standard): (IEEE-488.1) Configurable as talker/listener for computer control and fast data transfer. Command Language complies with

requirements of IEEE-488.2.

Centronics Port: Optional hardcopy parallel interface included with floppy disk and graphics printer option.

Hardcopy: Screen dumps are activated by a front-panel button or via remote control. TIFF format is available for importing into Desktop Publishing programs. The following printers and plotters can be used to make hardcopies:

HP DeskJet (color or B&W), HP ThinkJet, QuietJet, LaserJet, PaintJet and EPSON printers. HP 7400 and 7500 series, or HPGL compatible plotters. An optional internal high resolution graphics printer is also available.

GENERAL

Auto-calibration ensures specified DC and timing accuracy.

Temperature: 5° to 40° C (41° to 104° F) rated, 0° to 50° C (32° to 122° F) operating.

Humidity: < 80%.

Shock & Vibration: Meets MIL-STD-810C modified to LeCroy design specifications and MIL-T-28800C.

Power: 90-250 V AC, 45-66 Hz, 230 W.

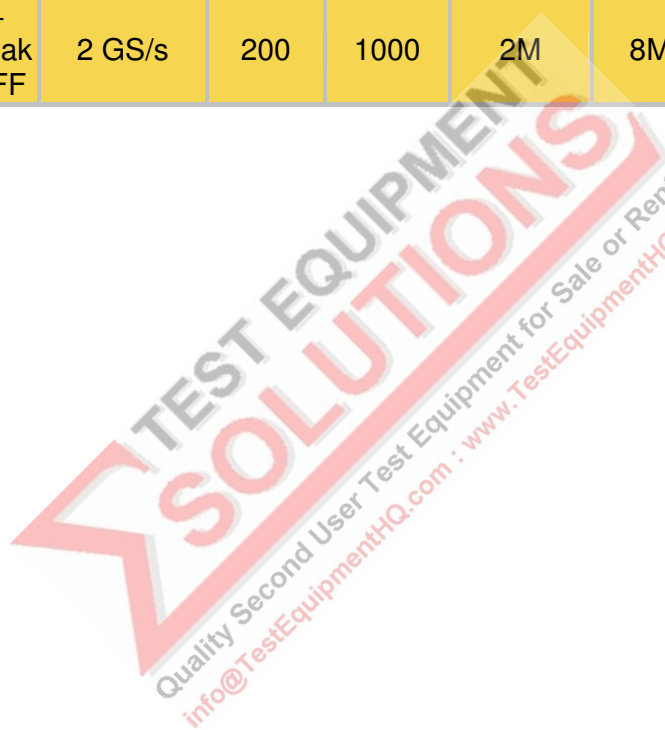
Battery Backup: Front-panel settings maintained for two years.

Dimensions: (HWD) 8.5" x 14.5" x 16.25", 210mm x 370mm x 410mm.

Weight: 13 kg (28.6 lbs) net,

18.5 kg (40.7 lbs) shipping.

Memory Per Channel						
Channels Used	Maximum Sample Rate	9350A 9354A	9350AM 9354AM	9354TM	9350AL 9354AL	Notes
All, Peak Detect OFF	500 MS/s	50k	250k	500k	2M	All channels active
All, Peak Detect ON	100 MS/s data 400 MS/s peak	25k data+ 25k peaks	100 data + 100 peaks	250k data + 250k peaks	1M data + 1M peaks	All channels active 2.5 ns peak detect
Paired Peak Detect OFF	1 GS/s	100	500	1M	4M	9350; CH1 9354A; Ch2 + Ch3
Paired + PP093 Peak Detect OFF	2 GS/s	200	1000	2M	8M	9354A Models Only


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